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FDMS0312AS N-Channel PowerTrench[®] SyncFETTM 30 V, 22 A, 5.0 m Ω

Features

- Max $r_{DS(on)} = 5.0 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$
- Max $r_{DS(on)} = 6.2 \text{ m}\Omega \text{ at } V_{GS} = 4.5 \text{ V}, I_D = 16 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

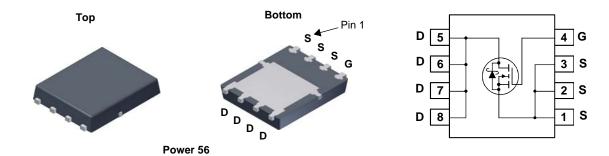


General Description

The FDMS0312AS has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance.This device has the added benefit of an efficient monolithic Schottky body diode.

Applications

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			30	V	
V _{GS}	Gate to Source Voltage		(Note 4)	±20	V	
ID	Drain Current -Continuous (Package limited)	$T_C = 25^{\circ}C$		22		
	-Continuous (Silicon limited)	$T_C = 25^{\circ}C$		70		
	-Continuous	T _A = 25°C	(Note 1a)	18	Α	
	-Pulsed			100		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	33	mJ	
P _D	Power Dissipation	T _C = 25°C		36	14/	
	Power Dissipation	$T_A = 25^{\circ}C$	(Note 1a)	2.5		
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

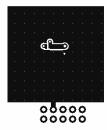
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.4	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 50	C/VV

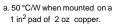
Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS0312AS	FDMS0312AS	Power 56	13 "	12 mm	3000 units

October 2014

Symbol	Parameter	s otherwise noted Test Conditions	Min	Тур	Max	Units	
Off Chara	octeristics						
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	30			V	
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to 25°C		18		mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			500	μA	
I _{GSS}	Gate to Source Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA	
	cteristics	00 20					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	1.2	1.5	3.0	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to 25°C		-4		mV/°C	
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 18 A		4.2	5.0	mΩ	
		$V_{GS} = 4.5 \text{ V}, I_D = 16 \text{ A}$		5.4	6.2		
		$V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}, T_J = 125^{\circ}\text{C}$		5.3	6.8		
9 _{FS}	Forward Transconductance	$V_{DS} = 5 V, I_{D} = 18 A$		92		S	
C _{oss} C _{rss}	Output Capacitance Reverse Transfer Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1MHz		550 70	730 105	pF pF	
						•	
R _g	Gate Resistance			0.5	2.5	Ω	
Switching	g Characteristics					1	
t _{d(on)}	Turn-On Delay Time			10	19	ns	
t _r	Rise Time	$V_{DD} = 15 \text{ V}, \text{ I}_{D} = 18 \text{ A},$		2.3	10	ns	
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		25	40	ns	
t _f	Fall Time			6	12	ns	
Q _g	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$		23 11	31 16	nC	
Q _g	Total Gate Charge Gate to Source Charge	$V_{GS} = 0 V \text{ to } 4.5 V$ $V_{DD} = 15 V,$ $I_D = 18 A$		3.3	10	nC nC	
Q _{gs}	Gate to Drain "Miller" Charge			3.3		nC	
Q _{gd}				5.7		no	
Jrain-Sol	urce Diode Characteristics						
Ver	Source-Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2 A$ (Note 2)		0.63	0.8	V	
Ven		$V_{GS} = 0 V, I_S = 18 A$ (Note 2)		0.8	1.2		
V _{SD}				00	20	00	
V _{SD} t _{rr} Q _{rr}	Reverse Recovery Time Reverse Recovery Charge	I _F = 18 A, di/dt = 300 A/μs		23 20	36 32	ns nC	

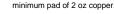


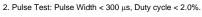




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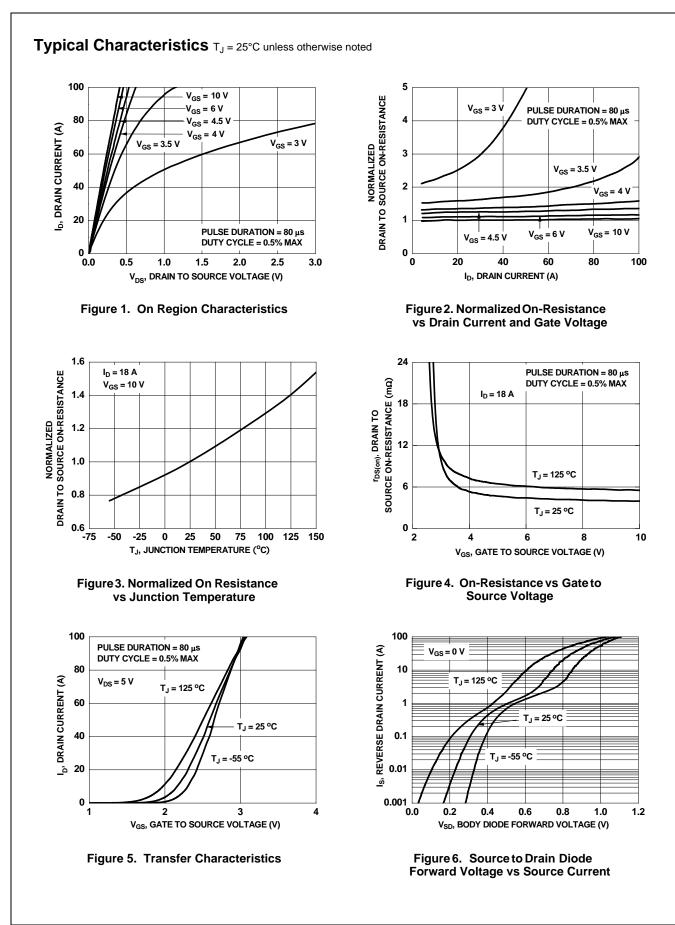
b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

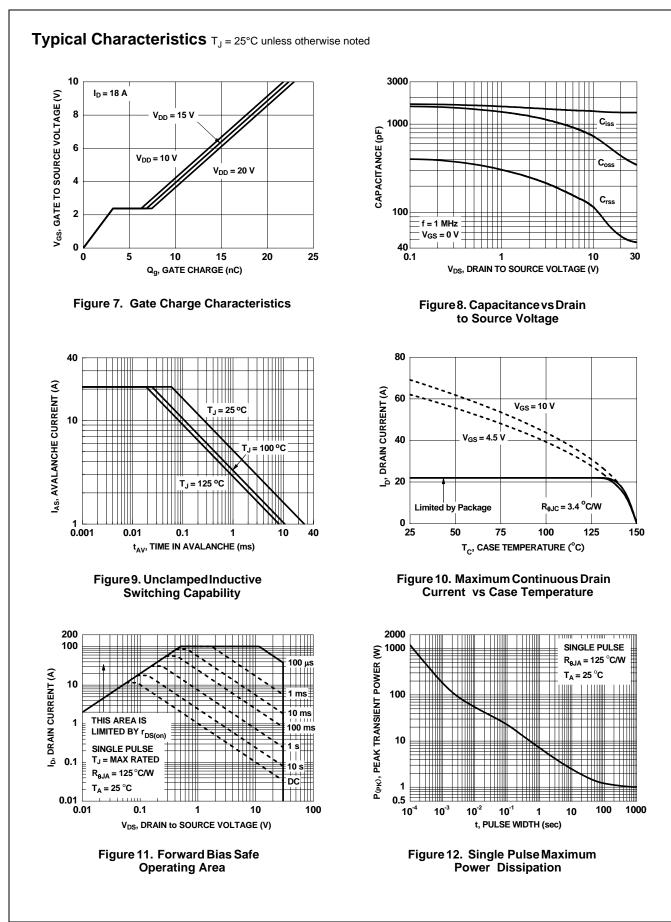


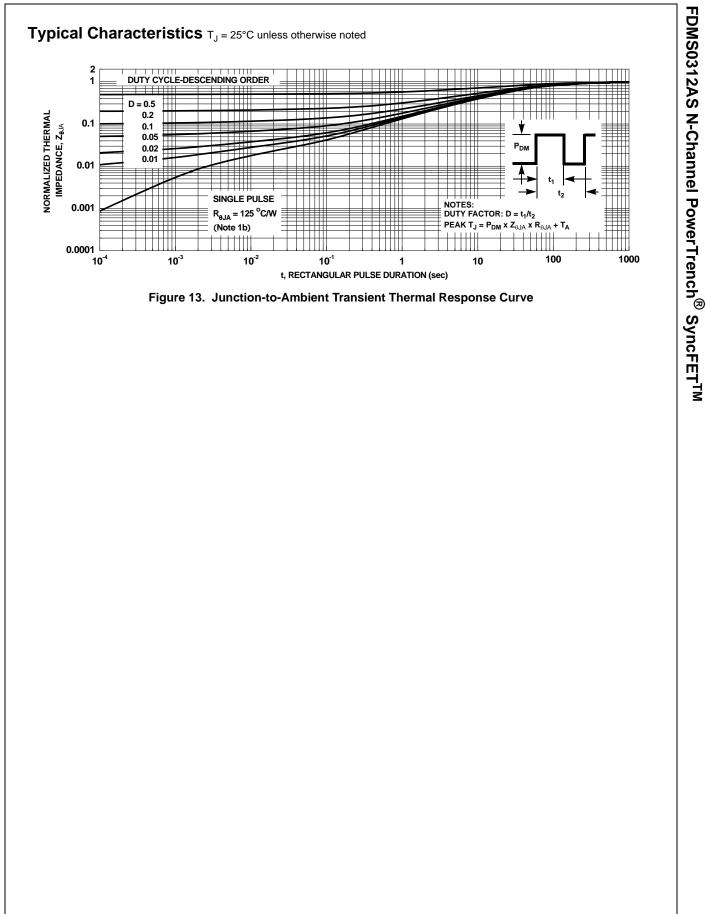


3. E_{AS} of 33 mJ is based on starting T_J = 25 °C, L = 0.3 mH, I_{AS} = 15 A, V_{DD} = 27 V, V_{GS} = 10 V.

4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.







Typical Characteristics (continued)

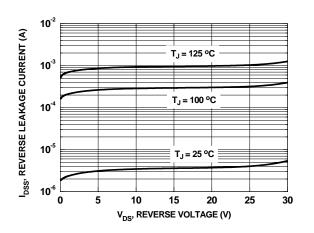
SyncFET Schottky body diode Characteristics

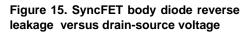
Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMS0312AS.

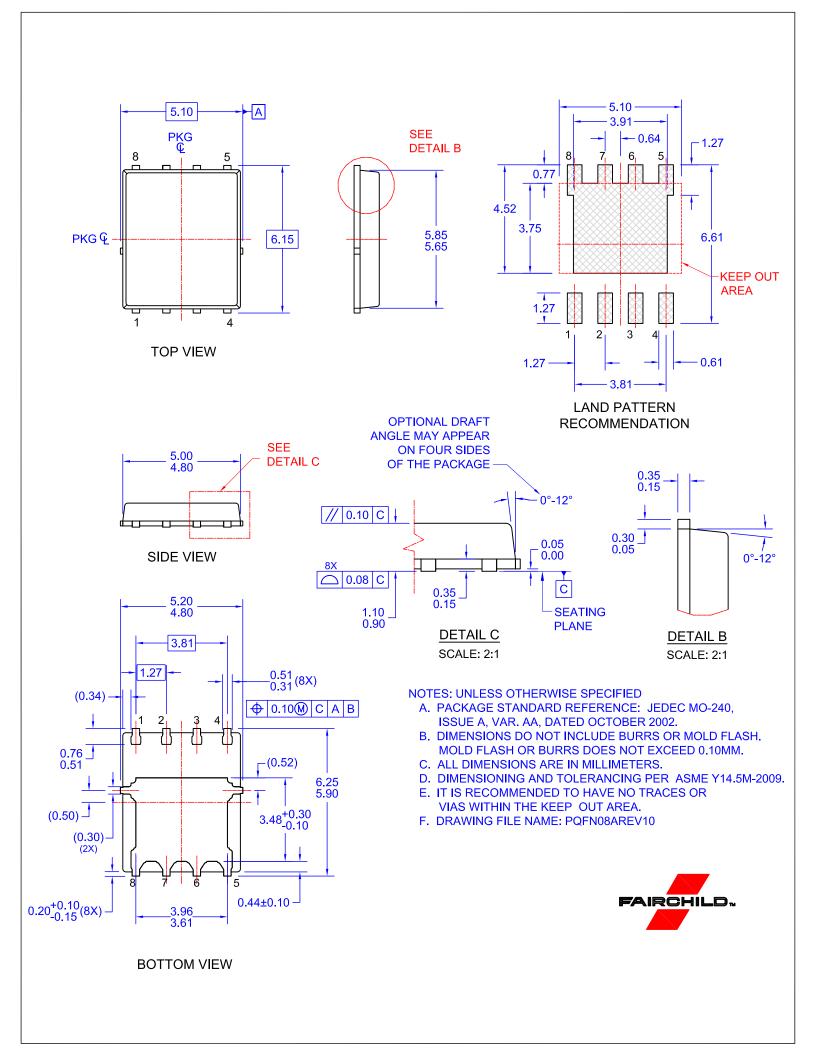
25 20 10 10 5 0 -5 10 20 30 40 50 TIME (ns)

Figure 14. FDMS0312AS SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.







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